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Supporting Information

Dual halogen layers diversify band engineering in Sillén oxyhalide photocatalysts: electronic structure control of $SrBi_3O_4X_3$ (X = Cl, Br, I) *via* halogen substitution

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Experimental section

Materials

 $SrCO_3$ (99.99%), BiOCl (95.0%), NaBr (99.5%), NaI (97%), Bi₂O₃ (99.9%), CH₃COONa (99.0%), CH₃COOH (99.7%), and Na₂SO₄ (99.0%) were purchased from FUJIFILM Wako Pure Chemical. Bi(NO₃)₃·5H₂O (99.5%) was purchased from Kanto Chemical. SrI₂ (99.99%) was purchased from Sigma Aldrich.

Sample synthesis

SrBi₃O₄X₃ (X = Cl, Br, and I) was prepared *via* solid-state reactions based on previously reported methods. ^{1,2} SrBi₃O₄Cl₃ was synthesized from a stoichiometric mixture of SrCO₃ and BiOCl. The mixture was then loaded into an alumina crucible and calcined at 973 K for 12 h in air. SrBi₃O₄Br₃ was prepared by heating a pellet of a stoichiometric mixture of SrCO₃ and BiOBr in an evacuated silica tube at 1073 K for 12 h. SrBi₃O₄I₃ was synthesized by calcining a mixture of SrI₂, Bi₂O₃, and BiOI in a molar ratio of 1.1:1:1 in an evacuated silica tube at 1073 K for 12 h. We used the as-purchased BiOCl and prepared BiOX (X = Br, I), which was synthesized by following a previously reported soft liquid deposition method.³

Characterization

Powder X-ray diffraction (MiniFlex II, Rigaku, CuK α X-ray source), UV–visible diffuse reflectance spectrometry (V–650, JASCO), and scanning electron microscopy (SEM; NVision 40, Carl Zeiss-SIINT) were used to characterize the samples. The scanning electron microscope was equipped with an energy-dispersive X-ray spectrometer. VESTA software was used to construct crystal structures.⁴

Electrochemical measurements

Mott–Schottky plots were measured using a three-electrode cell equipped with a Pt wire counter-electrode and Ag/AgCl reference electrode in a Na₂SO₄ solution (0.1 M, pH = 2.0, adjusted with 0.1 M H₂SO₄ aq.) using an electrochemical analyzer (VersaSTAT 4, Princeton Applied Research) with an amplitude of 10 mV and frequency of 500 and 1000 Hz. Electrodes were prepared using the squeegee method. A particulate sample containing a small amount of water was coated onto a fluorine-doped tin oxide conductive substrate and dried overnight at room temperature.

DFT calculations

The electronic structures of $SrBi_3O_4X_3$ (X = Cl, Br, I) were calculated using the Cambridge Serial Total Energy Package (CASTEP).⁵ The calculated models of $SrBi_3O_4X_3$ assumed that Bi^{3+} and Sr^{2+} are ordered at the Bi2/Sr2 site in a $\sqrt{2}\times\sqrt{2}\times1$ supercell (Fig. S5). The Perdew–Burke–Ernzerhof functional (PBE)

generalized gradient approximation (GGA) was used as the exchange-correlation functional,⁶ and the electronic states were expanded using a plane-wave basis set with a cutoff of 630 eV. The k-point meshes were set as $3 \times 3 \times 1$. Before the partial density of states (PDOS) calculation, geometry optimization was performed using the Broyden–Fletcher–Goldfarb–Shannon (BFGS) algorithm. The crystal orbital Hamilton population (COHP) was calculated using the Quantum Espresso package⁷ and Local-Orbital Basis Suite Toward Electronic-Structure Reconstruction (LOBSTER) package.⁸ The PBE functional for solids (PBEsol) GGA was used as the exchange-correlation functional.⁹ A cutoff energy of 100 Ry (~1361 eV) and $6 \times 6 \times 2$ k points were used. We confirmed that the calculated PDOS was similar to that calculated using CASTEP, as described above.

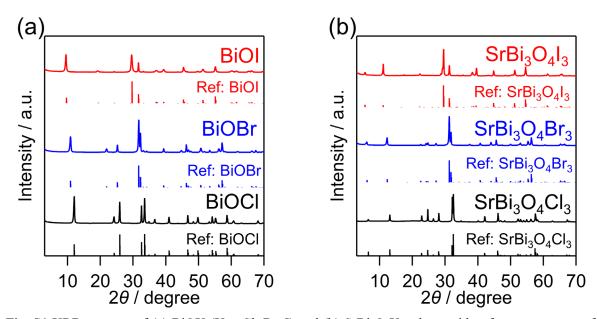


Fig. S1 XRD patterns of (a) BiOX (X = Cl, Br, I) and (b) $SrBi_3O_4X_3$, along with reference patterns of BiOCl (COD #4509949), BiOBr (COD #1010421), BiOI (COD #4341500), $SrBi_3O_4Cl_3$ (previous report¹⁰), $SrBi_3O_4Br_3$ (COD #1539104), and $SrBi_3O_4I_3$ (ICSD #76963).

Table S1 Average Sr/Bi and X/Bi atomic ratios in SrBi₃O₄X₃ (X = Cl, Br, I), determined from energy-dispersive X-ray spectroscopy mapping at three locations for each sample.

SrBi ₃ O ₄ X ₃	Sr/Bi	X/Bi
X = C1	0.30	0.82
X = Br	0.30	0.96
X = I	0.31	1.01

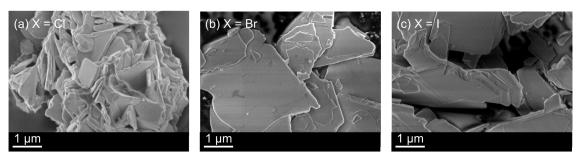


Fig. S2 SEM images of $SrBi_3O_4X_3$ (X = (a) Cl, (b) Br, (c) I).

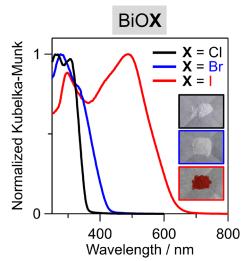


Fig. S3 UV-vis diffuse reflectance spectra of BiOX (X = Cl, Br, I).

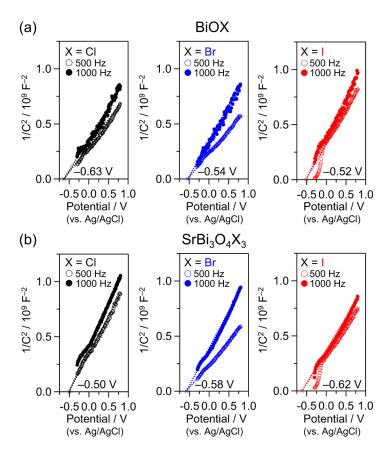


Fig. S4 Mott–Schottky plots for (a) BiOX (X = Cl, Br, I) and (b) $SrBi_3O_4X_3$.

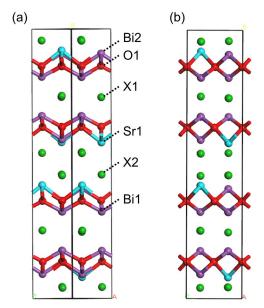


Fig. S5 Structural models of $SrBi_3O_4X_3$ (X = Cl, Br, I) used for the DFT calculations, viewed from two different directions corresponding to the [100] and [110] directions of the original structures.

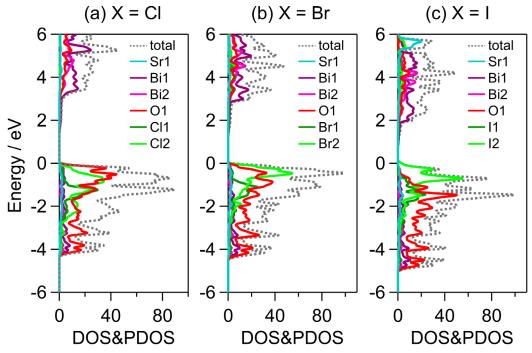


Fig. S6 DOS and PDOS near the VBM and CBM of $SrBi_3O_4X_3$ (X = (a) Cl, (b) Br, (c) I), calculated using the structural models shown in Fig. S5.

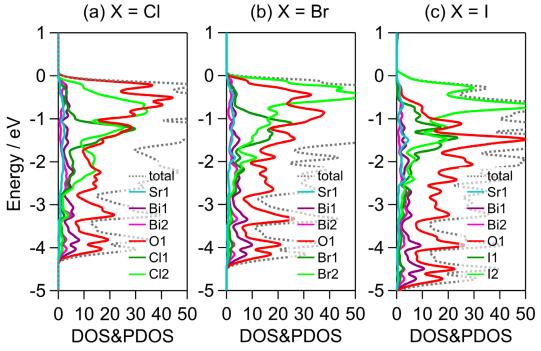


Fig. S7 Enlarged DOS and PDOS near the VBM of $SrBi_3O_4X_3$ (X = (a) Cl, (b) Br, (c) I), based on the structural models shown in Fig. S5.

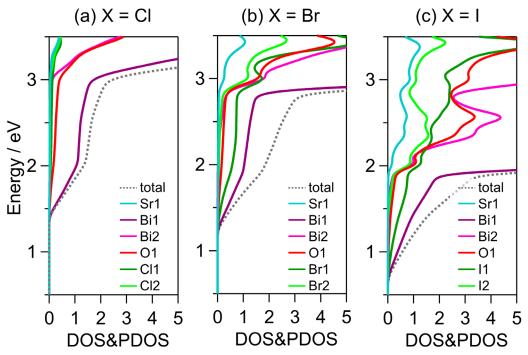


Fig. S8 Enlarged DOS and PDOS near the CBM of $SrBi_3O_4X_3$ (X = (a) Cl, (b) Br, (c) I), based on the structural models shown in Fig. S5.

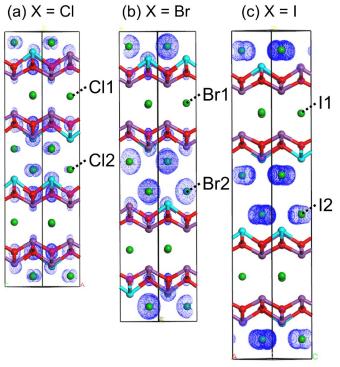


Fig. S9 Orbital distributions of the VBM (blue dots) estimated by DFT calculations for $SrBi_3O_4X_3$ (X = (a) Cl, (b) Br, (c) I) (isosurface values: 0.0075 e/Å³).

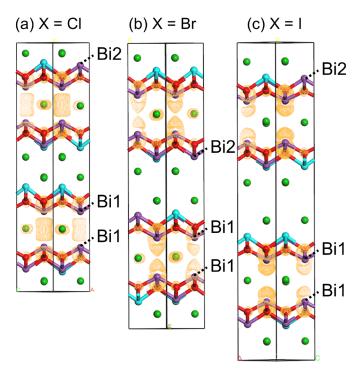


Fig. S10 Orbital distributions of the CBM (orange dots) estimated by DFT calculations for $SrBi_3O_4X_3$ (X = (a) Cl, (b) Br, (c) I) (isosurface values: 0.0075 e/Å³).

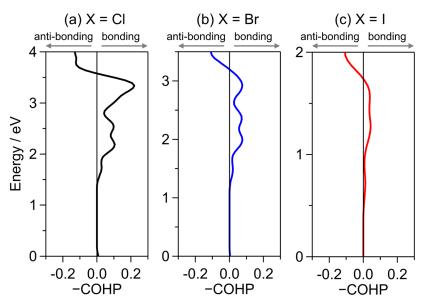


Fig. S11 COHPs for interlayer $Bi1(6p_z)$ – $Bi1(6p_z)$ interaction in $SrBi_3O_4X_3$ (X = (a) Cl, (b) Br, (c) I).

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